


<b>Search Notes</b>  	<b>Application/Control No.</b>  10647962	<b>Applicant(s)/Patent Under Reexamination</b>  LUND ET AL.
	<b>Examiner</b>  Hanh Nguyen	<b>Art Unit</b>  2416

SEARCHED			
Class	Subclass	Date	Examiner
370	390	11/25/08	hn
370	398		
370	389		
370	364		
370	465		
370	466		
709	203		
709	208		
709	209		
709	227		
709	223		
361	686		
361	788		
361	796		
710	2		
710	316	11/25/08	hn

SEARCH NOTES		
Search Notes	Date	Examiner
east	11/25/08	hn

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
370	389, 400, .398	11/25/08	hn
709	233, 219	11/25/08	hn
710	60	11/25/08	hn

	/H. N./ Primary Examiner.Art Unit 2416
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